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## AUIRF7759L2TR

- Advanced Process Technology
- Optimized for Automotive Motor Drive, DC-DC and other Heavy Load Applications

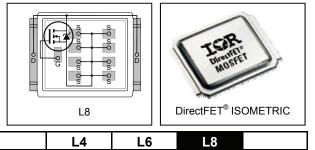
Applicable DirectFET<sup>®</sup> Outline and Substrate Outline ①

- Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- Lead free, RoHS and Halogen free
- Automotive Qualified \*

SC

	75V
Automotive DirectFEI	° Power MOSFET @

V <sub>(BR)DSS</sub>	75V
R <sub>DS(on)</sub> typ.	1.8mΩ
max.	2.3mΩ
D (Silicon Limited)	160A
<b>Q</b> g (typical)	200nC



#### Description

SB

The AUIRF7759L2TR(1) combines the latest Automotive HEXFET<sup>®</sup> Power MOSFET Silicon technology with the advanced DirectFET<sup>®</sup> packaging to achieve the lowest on-state resistance in a package that has the footprint of a DPak (TO-252AA) and only 0.7 mm profile. The DirectFET<sup>®</sup> package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET<sup>®</sup> package allows dual sided cooling to maximize thermal transfer in automotive power systems.

Μ4

M2

This HEXFET<sup>®</sup> Power MOSFET is designed for applications where efficiency and power density are essential. The advanced DirectFET<sup>®</sup> packaging platform coupled with the latest silicon technology allows the AUIRF7759L2TR(1) to offer substantial system level savings and performance improvement specifically in motor drive, high frequency DC-DC and other heavy load applications on ICE, HEV and EV platforms. This MOSFET utilizes the latest processing techniques to achieve low on-resistance and low Qg per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

Reas Part Number		Standard	Ordereble Dorf Number	
Base Part Number	Package Type	Form	Quantity	Orderable Part Number
AUIRF7759L2	DirectFET Large Can	Tape and Reel	4000	AUIRF7759L2TR

#### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	75	v
V <sub>GS</sub>	Gate-to-Source Voltage	±20	v
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) ④	160	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) ④	113	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) 3	26	A
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	375	
I <sub>DM</sub>	Pulsed Drain Current ©	640	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation ④	125	
$P_D @T_c = 100^{\circ}C$ Power Dissipation ④		63	W
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation ③	3.3	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 6	257	mJ
AR	Avalanche Current		Α
E <sub>AR</sub>	Repetitive Avalanche Energy S	See Fig. 16, 17, 18a, 18b	mJ
T <sub>P</sub>	Peak Soldering Temperature	270	
TJ			°C
T <sub>STG</sub>	Storage Temperature Range		

HEXFET® is a registered trademark of Infineon.

\*Qualification standards can be found at www.infineon.com



### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{ ext{ heta}JA}$	Junction-to-Ambient ③		45	
$R_{ ext{ heta}JA}$	Junction-to-Ambient ®	unction-to-Ambient   12.5		
$R_{ ext{ heta}JA}$	Junction-to-Ambient	ent (9 20		
$R_{ ext{ hetaJ-Can}}$	Junction-to-Can @ @ 1.2			
$R_{\theta J-PCB}$	Junction-to-PCB Mounted		0.5	
	Linear Derating Factor ④	0.83 W/°C		

## Static Electrical Characteristics @ $T_J$ = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	75			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.02		V/°C	Reference to $25^{\circ}$ C, I <sub>D</sub> = 2.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		1.8	2.3	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 96A ⊘
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	3.0	4.0	V	
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Coefficient		-11		mV/°C	$V_{DS} = V_{GS}, I_D = 250 \mu A$
gfs	Forward Transconductance	74			S	V <sub>DS</sub> = 25V, I <sub>D</sub> = 96A
	Drain to Source Lookage Current			20		V <sub>DS</sub> = 75V, V <sub>GS</sub> = 0V
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	<b>n</b> A	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -20V

## Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

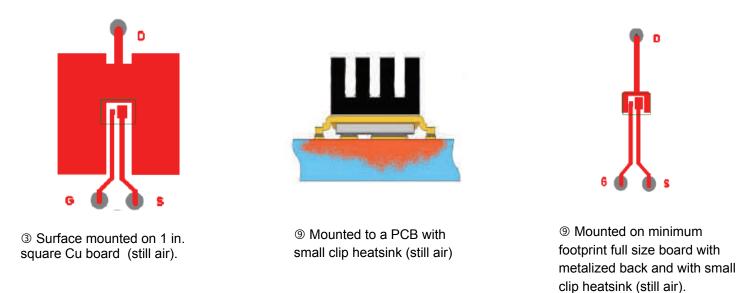
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge		200	300		V <sub>DS</sub> = 38V
Q <sub>gs1</sub>	Gate-to-Source Charge		37			V <sub>GS</sub> = 10V
Q <sub>gs2</sub>	Gate-to-Source Charge		11			I <sub>D</sub> = 96A
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		62	93	nC	See Fig.11
Q <sub>godr</sub>	Gate Charge Overdrive		91			
Q <sub>sw</sub>	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		73			
Q <sub>oss</sub>	Output Charge		60		nC	V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V
R <sub>G</sub>	Internal Gate Resistance		1.1		Ω	
t <sub>d(on)</sub>	Turn-On Delay Time		18			V <sub>DD</sub> = 38V, V <sub>GS</sub> = 10V ⑦
t <sub>r</sub>	Rise Time		37			I <sub>D</sub> = 96A
t <sub>d(off)</sub>	Turn-Off Delay Time		80		ns	R <sub>G</sub> = 1.8Ω
t <sub>f</sub>	Fall Time		33			
C <sub>iss</sub>	Input Capacitance		12222			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		1465			V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		609		pF	f = 1.0 MHz
C <sub>oss</sub>	Output Capacitance		7457		1	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0 \text{ MHz}$
C <sub>oss</sub>	Output Capacitance		955			$V_{GS} = 0V, V_{DS} = 60V, f = 1.0 \text{ MHz}$

### Notes ${\rm \textcircled{O}}$ through ${\rm \textcircled{O}}$ are on page 3



#### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
1	Continuous Source Current			160		MOSFET symbol
IS	(Body Diode)			160	_	showing the
1	Pulsed Source Current			640	A	integral reverse
ISM	(Body Diode) (S		640	- 640		p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 96A, V_{GS} = 0V $
t <sub>rr</sub>	Reverse Recovery Time		64	96	ns	$T_J = 25^{\circ}C, I_F = 96A, V_{DD} = 38V$
Q <sub>rr</sub>	Reverse Recovery Charge		150	225	nC	dv/dt = 100A/µs ⊘



- 0 Click on this section to link to the appropriate technical paper. 0 Click on this section to link to the DirectFET Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- ④ T<sub>c</sub> measured with thermocouple mounted to top (Drain) of part.
- © Repetitive rating; pulse width limited by max. junction temperature.
- 6 Starting T<sub>J</sub> = 25°C, L = 0.056mH, R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 96A.
- $\bigcirc$  Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.
- Ised double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heat sink.
- **(1)**  $R_{\theta}$  is measured at T<sub>J</sub> of approximately 90°C.



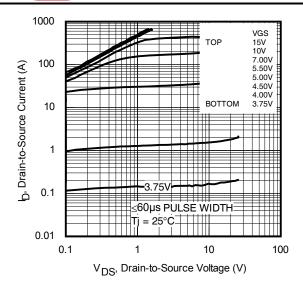


Fig. 1 Typical Output Characteristics

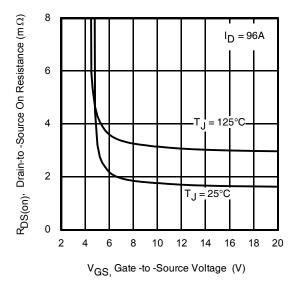


Fig. 3 Typical On-Resistance vs. Gate Voltage

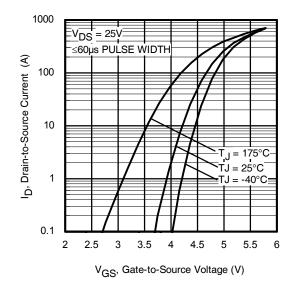
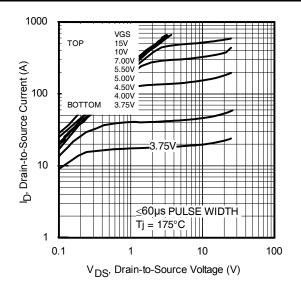
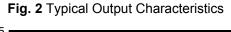


Fig 5. Typical Transfer Characteristics

## AUIRF7759L2TR





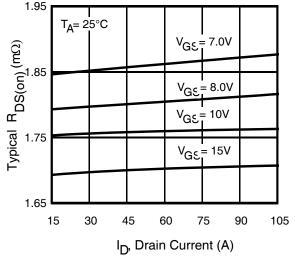


Fig. 4 Typical On-Resistance vs. Drain Current

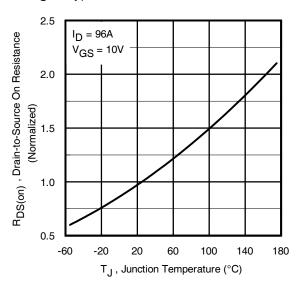
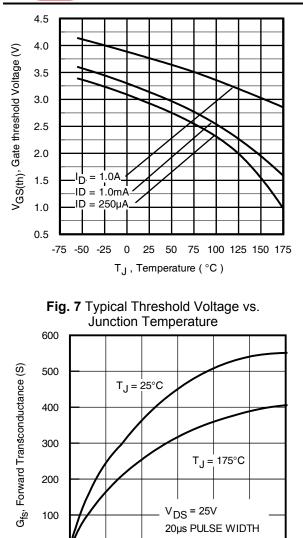


Fig 6. Normalized On-Resistance vs. Temperature





50 100 150 200 250 300 I<sub>O</sub>,Drain-to-Source Current (A)

Fig 9. Typical Forward Trans conductance vs. Drain Current

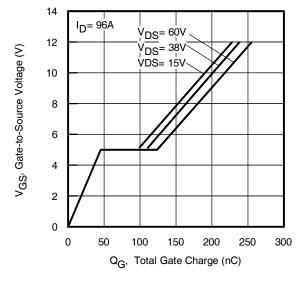
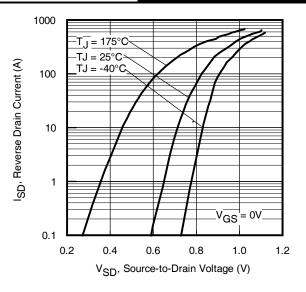
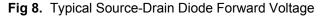
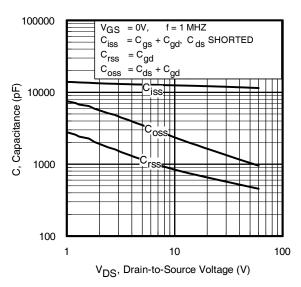


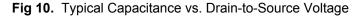
Fig 11. Typical Gate Charge vs. Gate-to-Source Voltage

## AUIRF7759L2TR









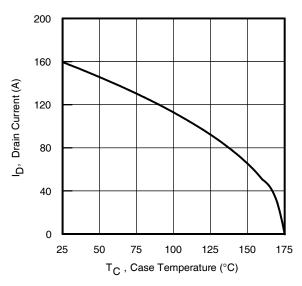


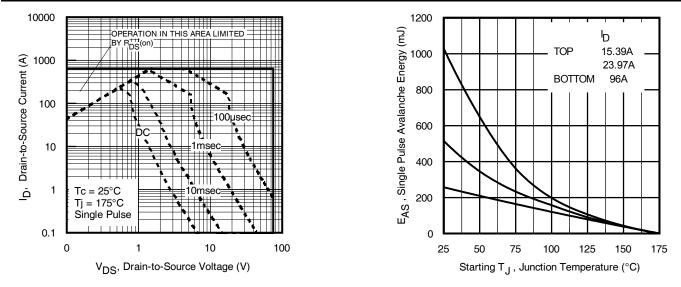
Fig 12. Maximum Drain Current vs. Case Temperature

0

0



## AUIRF7759L2TR



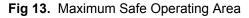
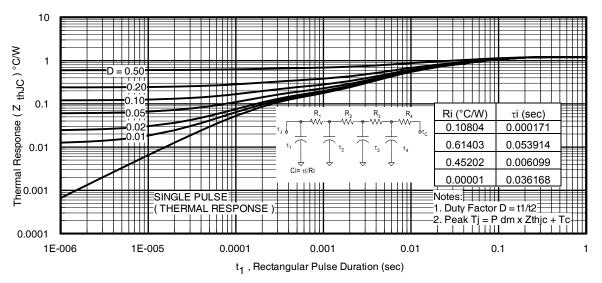
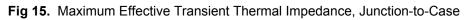
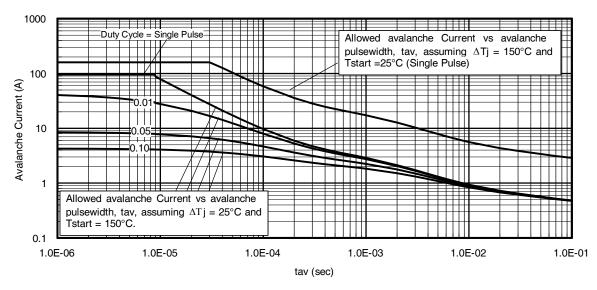
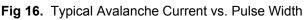


Fig 14. Maximum Avalanche Energy vs. Temperature

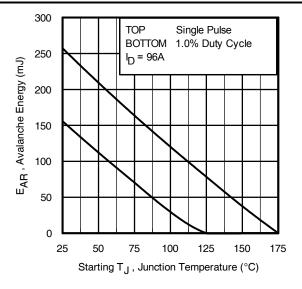


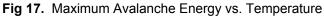












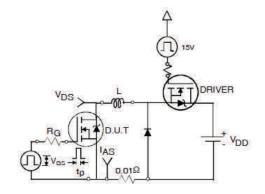


Fig 18a. Unclamped Inductive Test Circuit

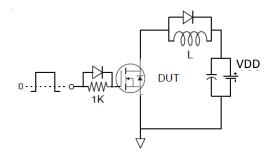


Fig 19a. Gate Charge Test Circuit

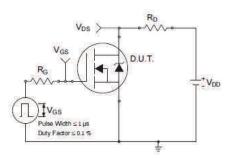
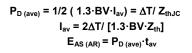


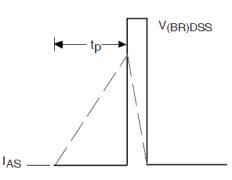
Fig 20a. Switching Time Test Circuit

## Notes on Repetitive Avalanche Curves , Figures 16, 17:

- (For further info, see AN-1005 at www.infineon.com)
- 1. Avalanche failures assumption: Purely a thermal phenomenon and failu
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 16, 17).
  - tav = Average time in avalanche.
  - D = Duty cycle in avalanche =  $t_{av} \cdot f$

ZthJC(D, tav) = Transient thermal resistance, see Figures 15)





#### Fig 18b. Unclamped Inductive Waveforms

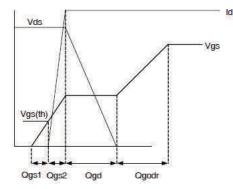


Fig 19b. Gate Charge Waveform

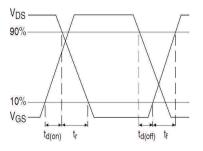
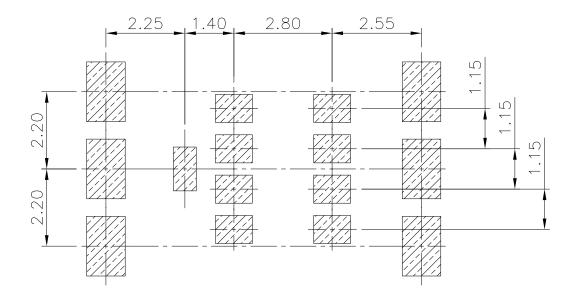


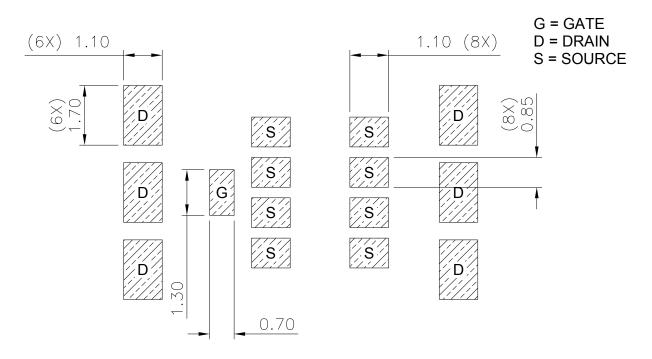
Fig 20b. Switching Time Waveforms



## DirectFET<sup>®</sup> Board Footprint, L8 (Large Size Can).

Please see DirectFET<sup>®</sup> application note AN-1035 for all details regarding the assembly of DirectFET<sup>®</sup>. This includes all recommendations for stencil and substrate designs.



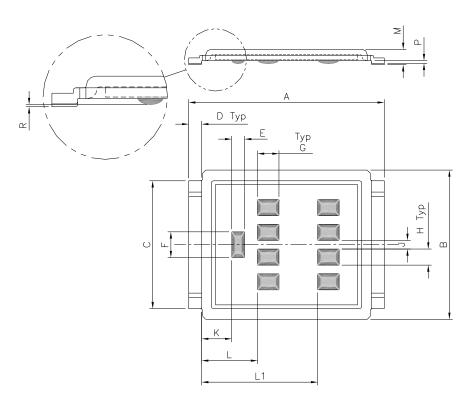


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



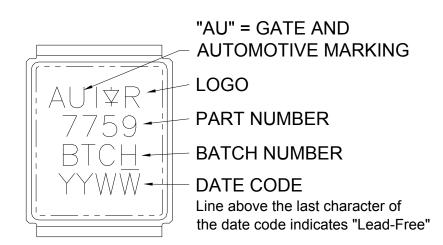
## DirectFET<sup>®</sup> Outline Dimension, L8 (Large Size Can).

Please see DirectFET<sup>®</sup> application note AN-1035 for all details regarding the assembly of DirectFET<sup>®</sup>. This includes all recommendations for stencil and substrate designs.



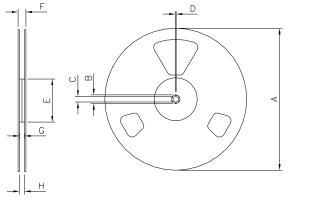
DIMENSIONS						
	ME	RIC	IMPE	RIAL		
CODE	MIN	MAX	MIN	MAX		
Α	9.05	9.15	0.356	0.360		
В	6.85	7.10	0.270	0.280		
С	5.90	6.00	0.232	0.236		
D	0.55	0.65	0.022	0.026		
Е	0.58	0.62	0.023	0.024		
F	1.18	1.22	0.046	0.048		
G	0.98	1.02	0.039	0.040		
Н	0.73	0.77	0.029	0.030		
J	0.38	0.42	0.015	0.017		
К	1.35	1.45	0.053	0.057		
L	2.55	2.65	0.100	0.104		
L1	5.35	5.45	0.211	0.215		
М	0.68	0.74	0.027	0.029		
Р	0.09	0.17	0.003	0.007		
R	0.02	0.08	0.001	0.003		

DirectFET<sup>®</sup> Part Marking



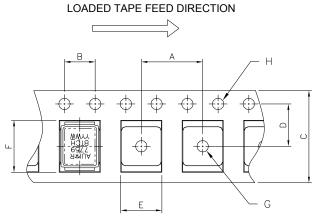
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

## DirectFET<sup>®</sup> Tape & Reel Dimension (Showing component orientation)



NOTE: Controlling dimensions in mm Std reel quantity is 4000 parts, ordered as AUIRF7759L2TR.

REEL DIMENSIONS						
ST	ANDARD	OPTION	(QTY 400	)0)		
	MET	RIC	IMPE	RIAL		
CODE	MIN	MAX	MIN	MAX		
Α	330.00	N.C	12.992	N.C		
В	20.20	N.C	0.795	N.C		
С	12.80	13.20	0.504	0.520		
D	1.50	N.C	0.059	N.C		
E	99.00	100.00	3.900	3.940		
F	N.C	22.40	N.C	0.880		
G	16.40	18.40	0.650	0.720		
н	15 90	19 40	0.630	0 760		



		DI	MENSION	١S	
		MET	RIC	IMPE	RIAL
NOTE: CONTROLLING DIMENSIONS IN MM	CODE	MIN	MAX	MIN	MAX
	A	11.90	12.10	4.69	0.476
	В	3.90	4.10	0.154	0.161
	С	15.90	16.30	0.623	0.642
	D	7.40	7.60	0.291	0.299
	E	7.20	7.40	0.283	0.291
	F	9.90	10.10	0.390	0.398
	G	1.50	N.C	0.059	N.C
	Н	1.50	1.60	0.059	0.063

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

### **Qualification Information**

		Automotive				
Qualification Level		(per AEC-Q101)				
		Comments: This part number(s) pas	sed Automotive qualification. Infineon's			
		Industrial and Consumer qualification le	evel is granted by extension of the higher			
		Automotive level.				
Moisture S	Sensitivity Level	DFET2 Large Can	MSL1			
	Machine Medal	Class M4 (+/- 800V) <sup>†</sup>				
	Machine Model	AEC-Q101-002				
505		Class H2 (+/- 6000V) <sup>†</sup>				
ESD	Human Body Model	AEC-Q101-001				
		N/A				
Charged Device Model		AEC-Q101-005				
RoHS Compliant		Yes				

† Highest passing voltage.

#### **Revision History**

Date	Comments
10/5/2015	<ul> <li>Updated datasheet with corporate template</li> <li>Corrected ordering table on page 1.</li> <li>Updated Tape and Reel option on page 10</li> </ul>

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